

Fundamentals of Nanotransistors

Unit 3: The Ballistic Nanotransistor

Lecture 3.7: Unit 3 Summary

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Our goal in Unit 3

A ballistic treatment of transport

$$I_{DS} = W |Q_n(V_{GS}, V_{DS})| \langle v(V_{GS}, V_{DS}) \rangle$$

*Unit 2:
MOS electrostatics*

Unit 3

Lecture 3.1: Introduction

Lecture 3.2: Landauer Approach

Lecture 3.3: More on Landauer

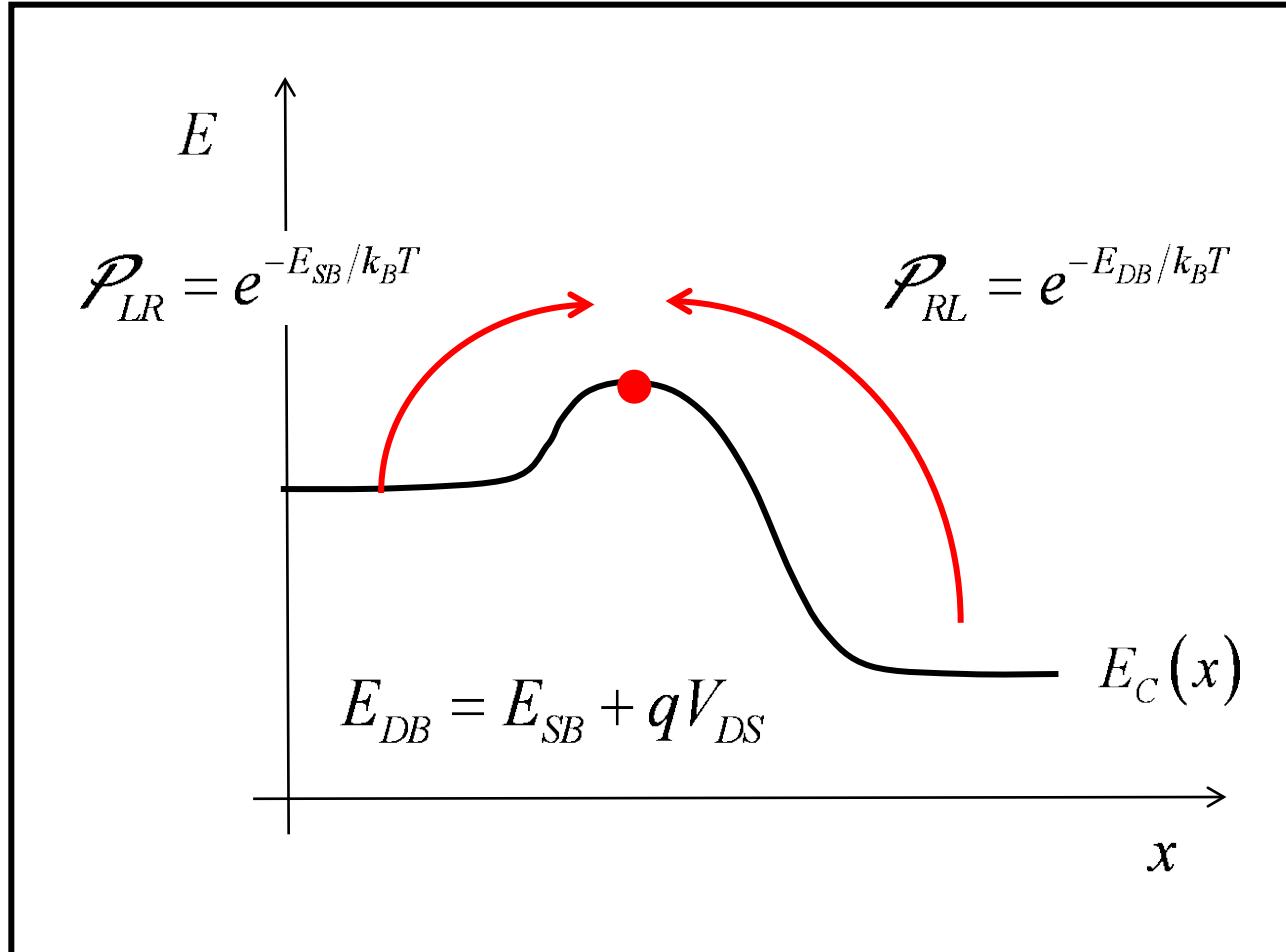
Lecture 3.4: The Ballistic MOSFET

Lecture 3.5: The Velocity at the VS

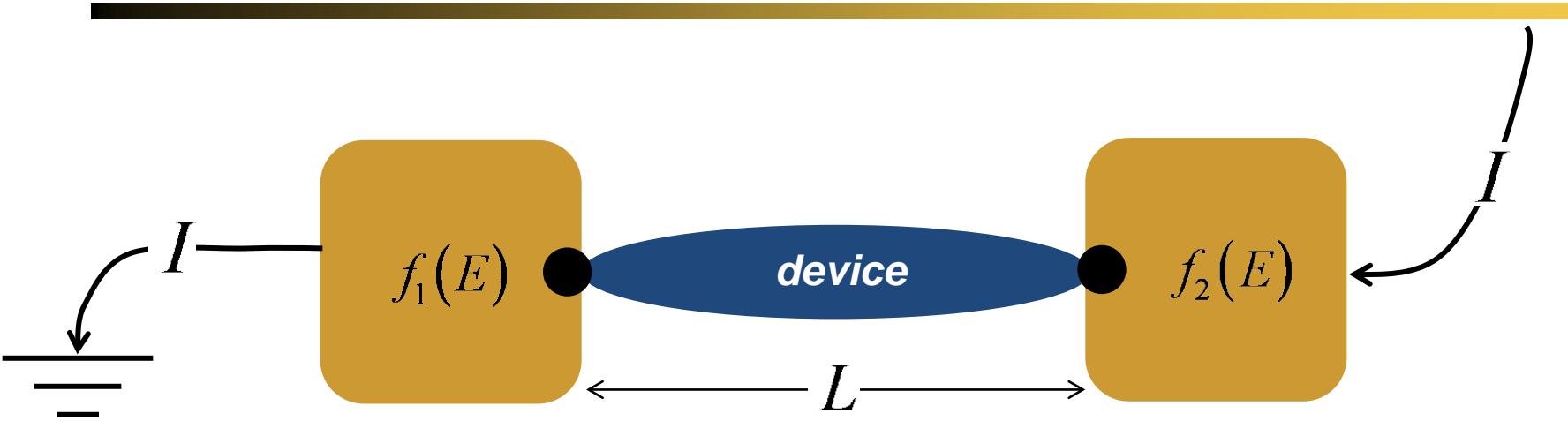
Lecture 3.6: Revisiting the VS Model

Lecture 3.7 Summary

Lecture 3.1: thermionic emission



Lecture 3.2: Landauer Approach



$$f_1(E) = \frac{1}{1 + e^{(E - E_{F1})/k_B T_1}}$$

$$f_2(E) = \frac{1}{1 + e^{(E - E_{F2})/k_B T_2}}$$

$$E_{F2} = E_{F1} - qV$$

$$I = \frac{2q}{h} \int \mathcal{T}(E) M(E) (f_1(E) - f_2(E)) dE$$

$$n_s = \int_{E_C}^{\infty} \left(\frac{D_{2D}(E)}{2} f_1(E) + \frac{D_{2D}(E)}{2} f_2(E) \right) dE \text{ m}^{-2}$$

Landauer Approach

$$I = \frac{2q}{h} \int T(E) M(E) (f_1(E) - f_2(E)) dE$$

Fundamental constants

Transmission:

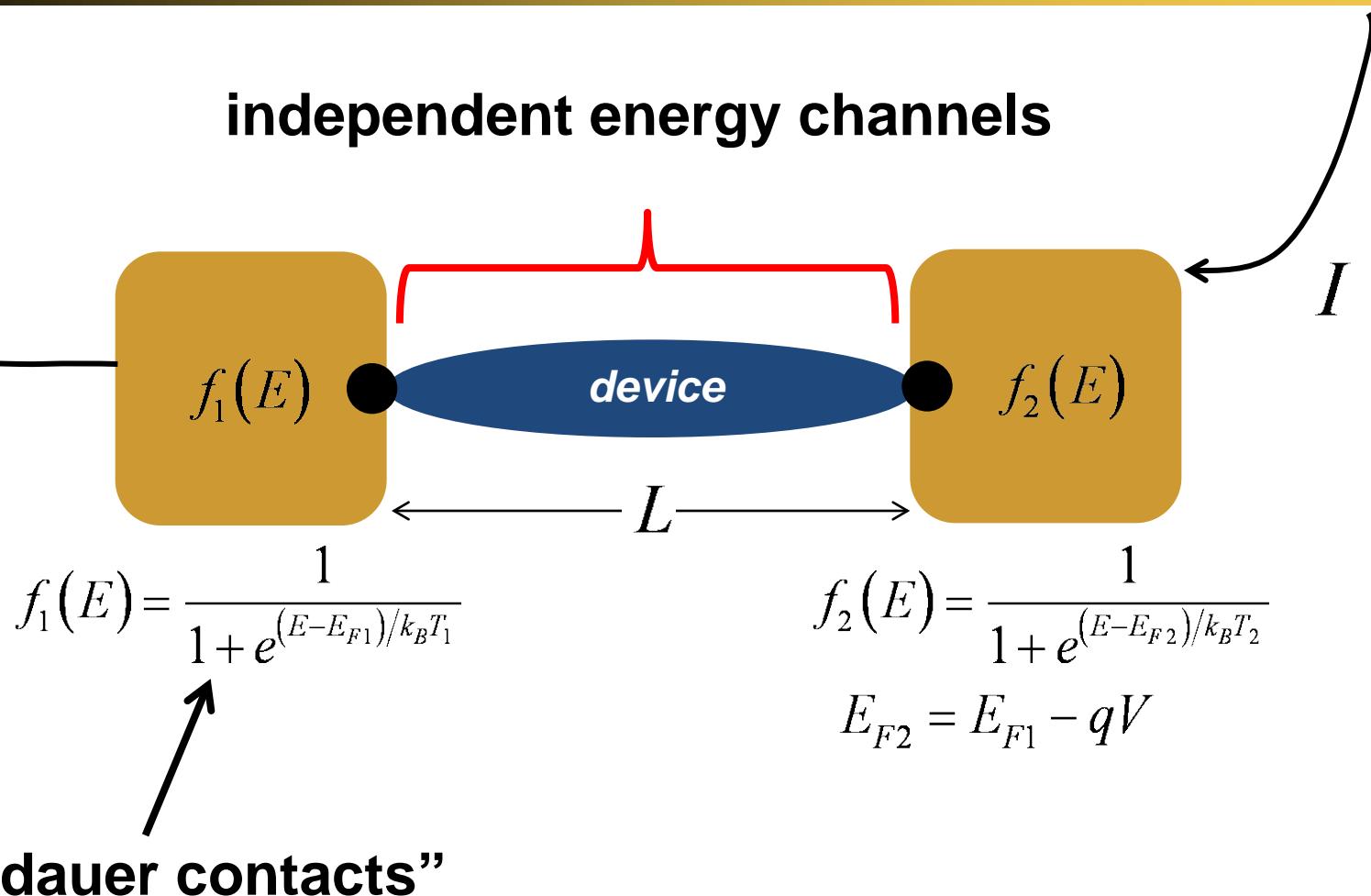
$T(E) = 1$ ballistic

$T(E) \ll 1$ diffusive

Channels
or
Modes

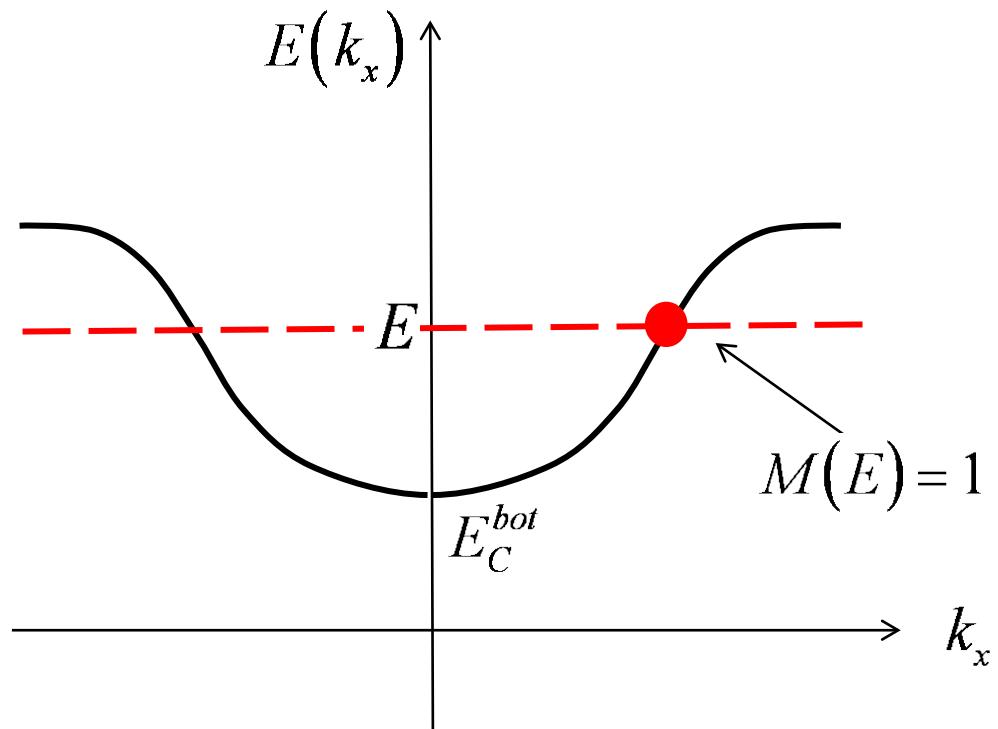
Ideal
“Landauer”
contacts

Lecture 3.2: Landauer Approach



Channels (modes)

$$M_{1D}(E) \equiv \frac{\hbar}{4} \langle v_x^+(E) \rangle D_{1D}(E)$$



(Easily generalized to arbitrary bandstructures in 1D, 2D, and 3D.)

Lecture 3.3: The Fermi window

$$I = \frac{2q}{h} \int \mathcal{T}(E) M(E) (f_1 - f_2) dE$$

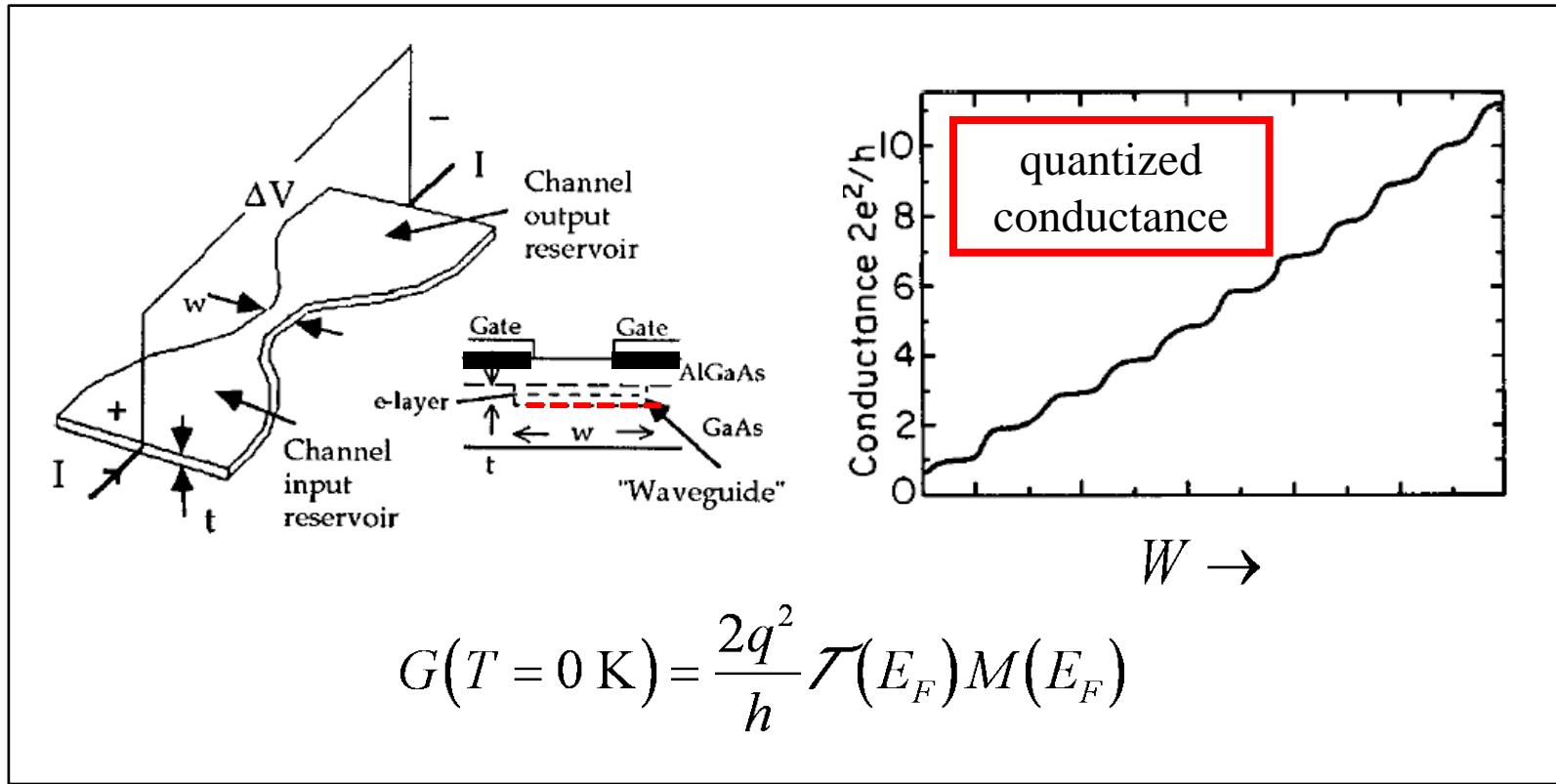
The range of energies over which $(f_1 - f_2) \neq 0$

Linear response: $f_1(E) - f_2(E) = \left(-\frac{\partial f_1}{\partial E} \right) (qV)$

$$I = GV \text{ A}$$

$$G = \frac{2q^2}{h} \int \mathcal{T}(E) M(E) \left(-\frac{\partial f_0}{\partial E} \right) dE \text{ S}$$

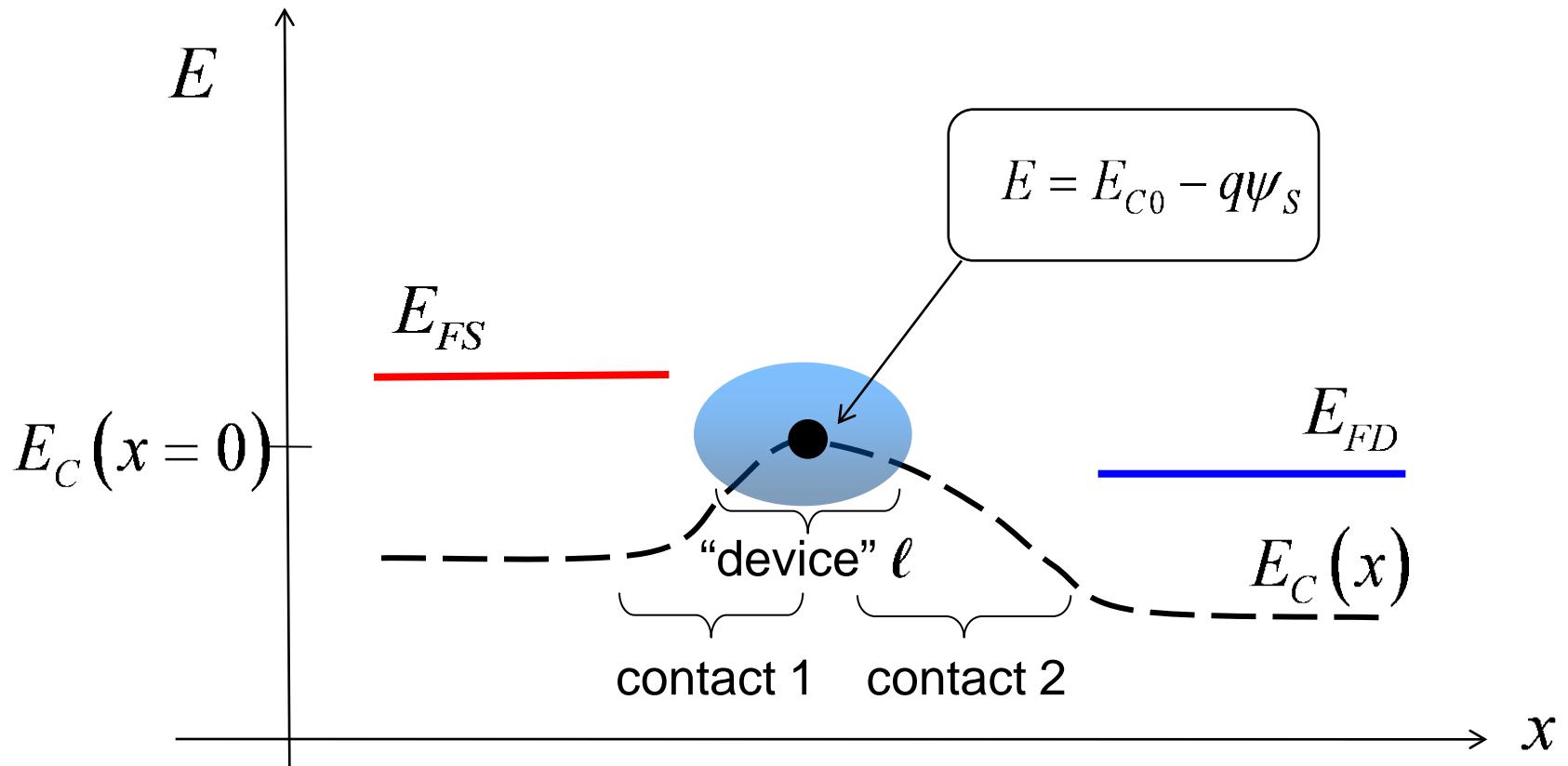
Quantized conductance



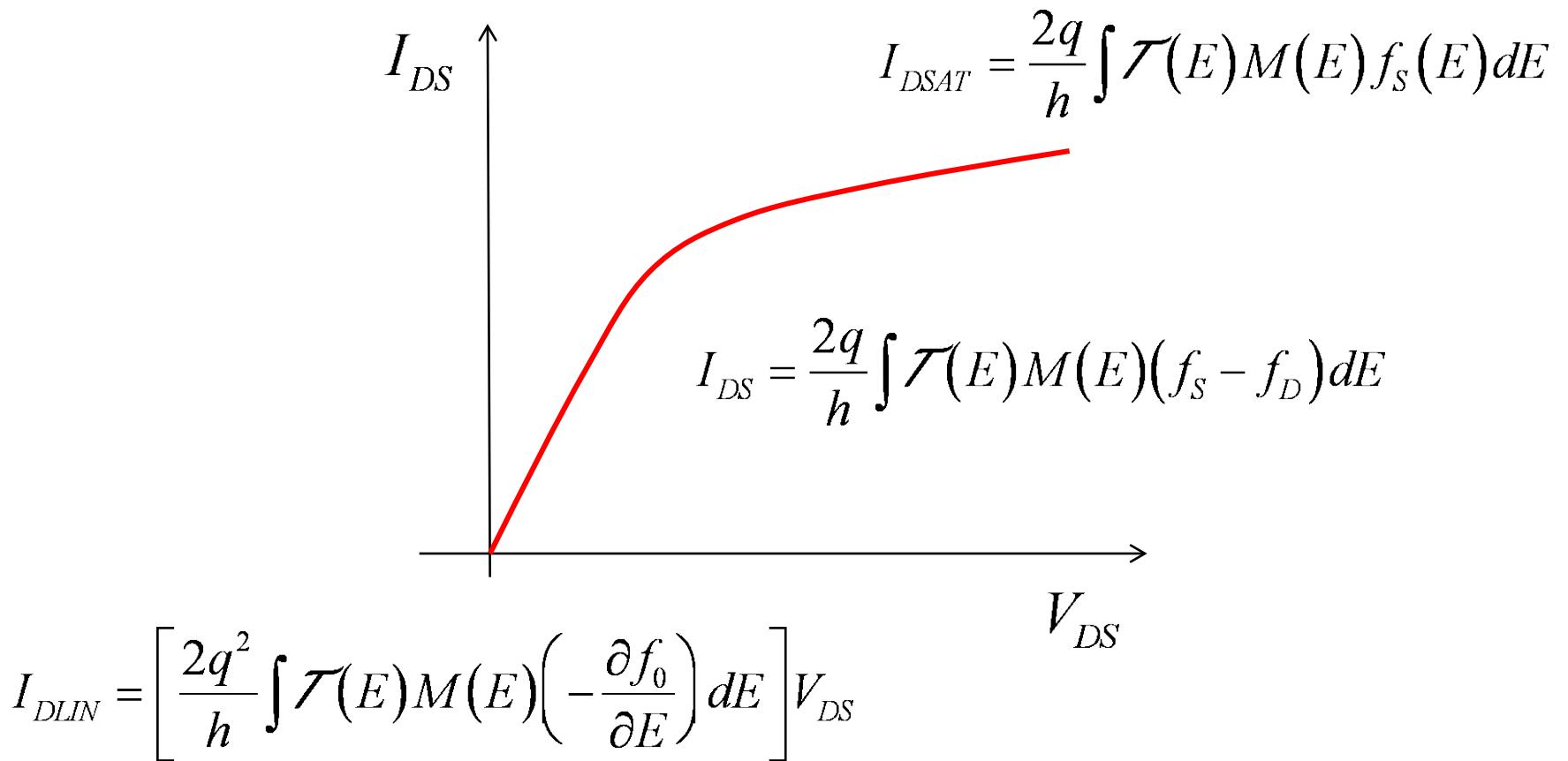
D. Holcomb, *American J. Physics*, **67**, pp. 278-297 1999.

Data from: B. J. van Wees, et al., *Phys. Rev. Lett.* **60**, 848851, 1988.

Lecture 3.4: The Ballistic MOSFET

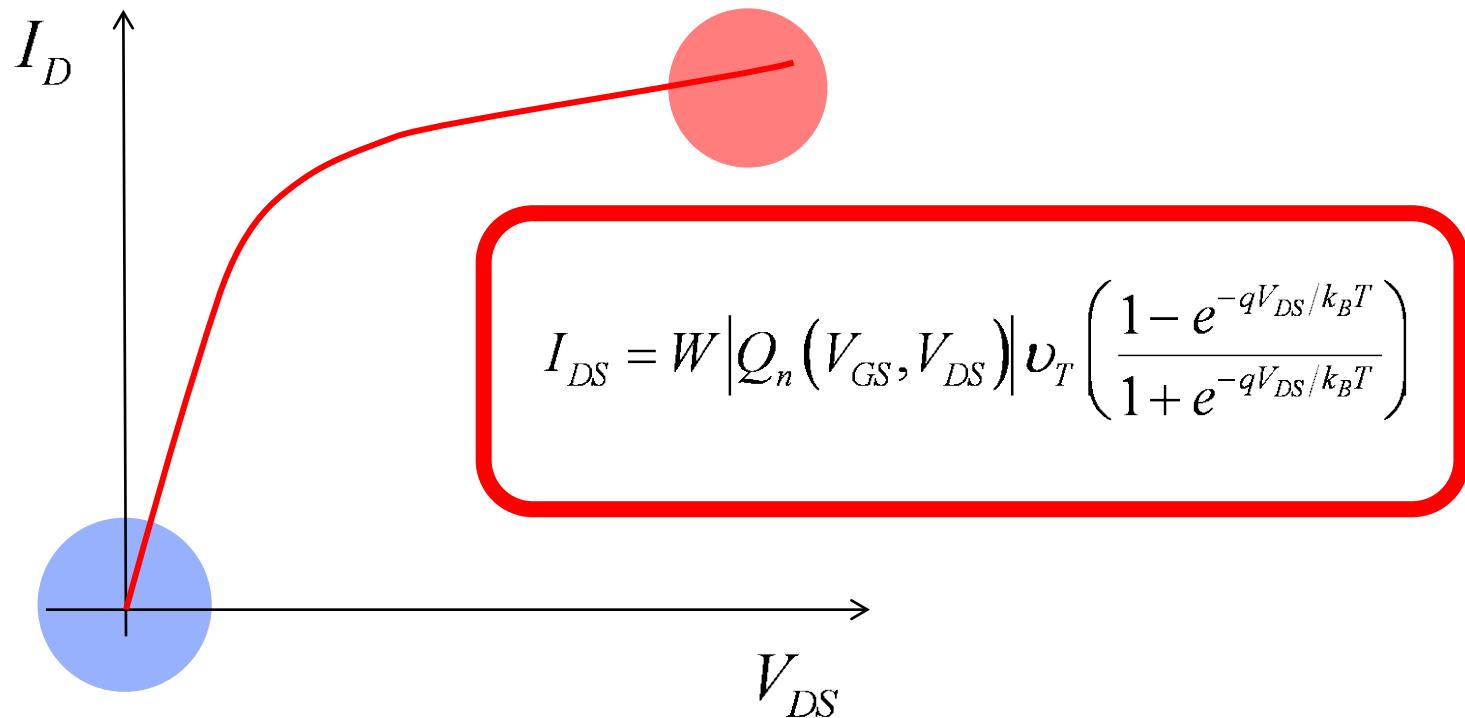


Ballistic MOSFET



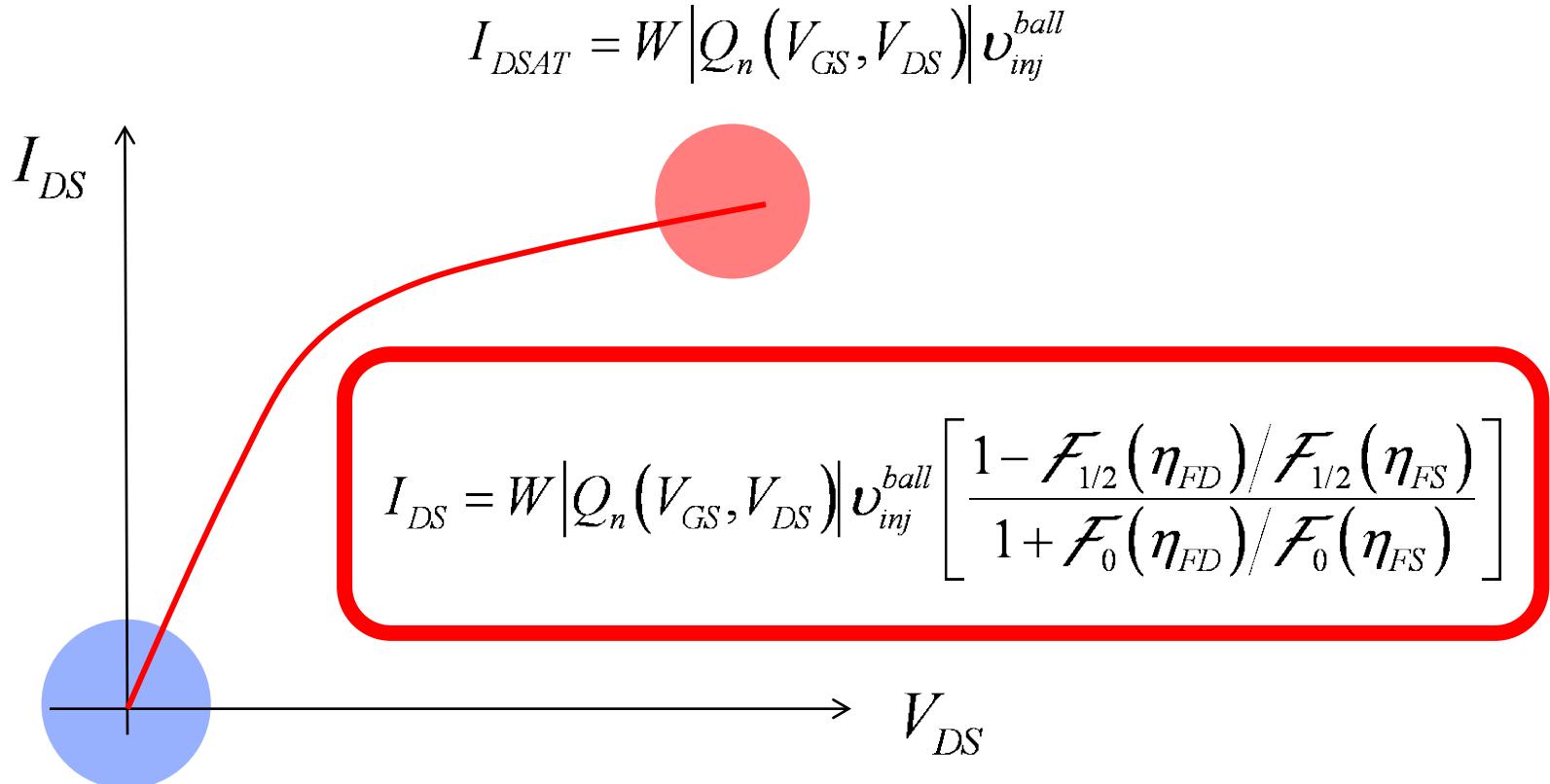
Ballistic MOSFET: nondegenerate

$$I_{DSAT} = W |Q_n(V_{GS}, V_{DS})| v_T$$



$$I_{DLN} = W \frac{v_T}{2k_B T/q} |Q_n(V_{GS}, V_{DS})| V_{DS}$$

Ballistic MOSFET: degenerate



$$I_{DLIN} = W |Q_n(V_{GS}, V_{DS})| \frac{v_{inj}^{ball}}{2k_B T/q} \left\{ \frac{\mathcal{F}_{-1/2}(\eta_{FS})}{\mathcal{F}_{1/2}(\eta_{Fs})} \right\} V_{DS} \quad (\text{See Sec. 13.6 of Lecture Notes.})$$

FD statistics: Prescription

3)

$$I_{DS} = W \left| Q_n(V_{GS}, V_{DS}) \right| v_{inj}^{ball} \left[\frac{1 - \mathcal{F}_{1/2}(\eta_{FD}) / \mathcal{F}_{1/2}(\eta_{FS})}{1 + \mathcal{F}_0(\eta_{FD}) / \mathcal{F}_0(\eta_{FS})} \right]$$

1)

$$Q_n(V_{GS}, V_{DS}) = -q \frac{N_{2D}}{2} (\mathcal{F}_0(\eta_{FS}) + \mathcal{F}_0(\eta_{FD})) m^{-2}$$

2)

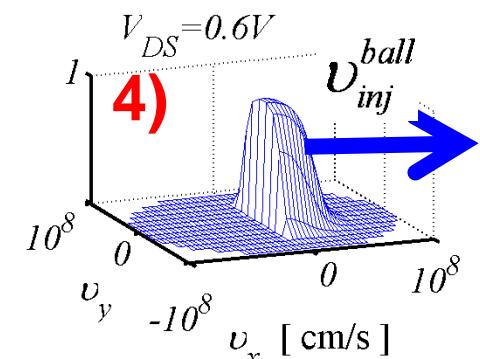
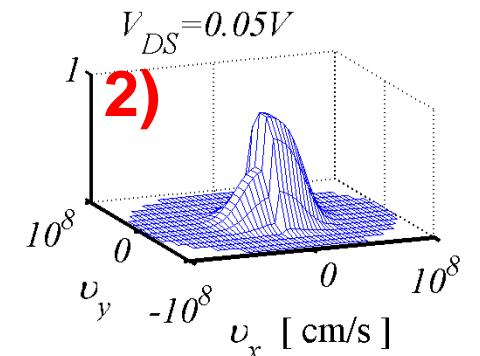
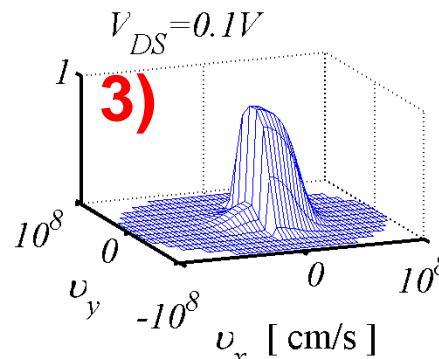
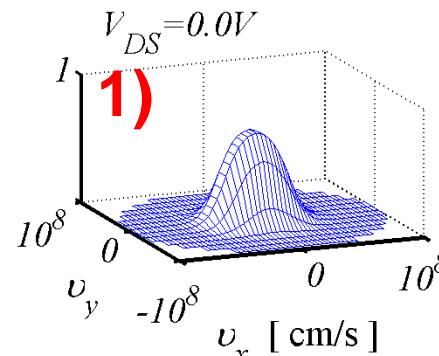
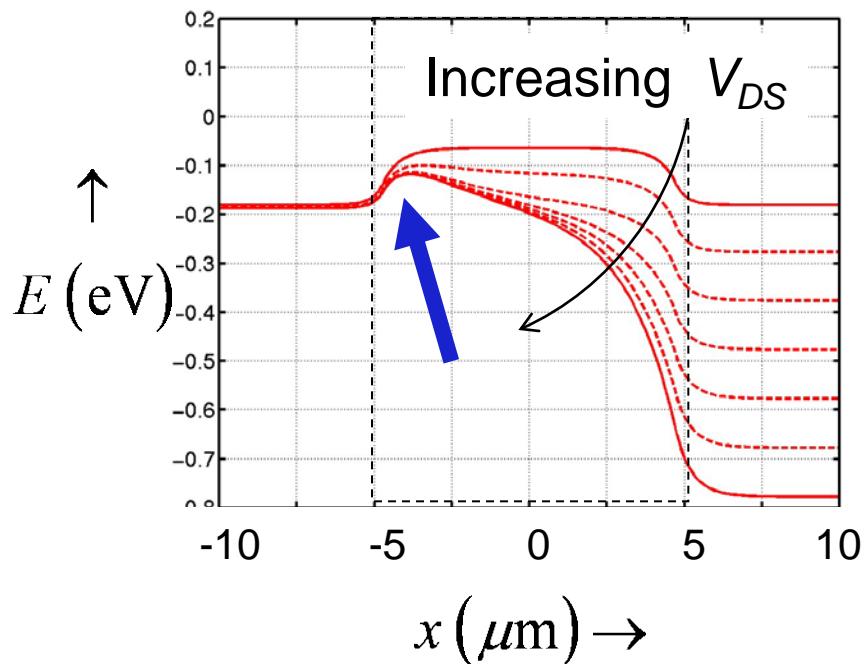
$$v_{inj}^{ball} = \langle \langle v_x^+ \rangle \rangle = v_T \frac{\mathcal{F}_{1/2}(\eta_{FS})}{\mathcal{F}_0(\eta_{FS})} \quad v_T = \sqrt{\frac{2k_B T}{\pi m^*}}$$

$$\eta_{FD} = \eta_{FS} - qV_{DS}/k_B T$$

Lecture 3.5: Velocity at the VS

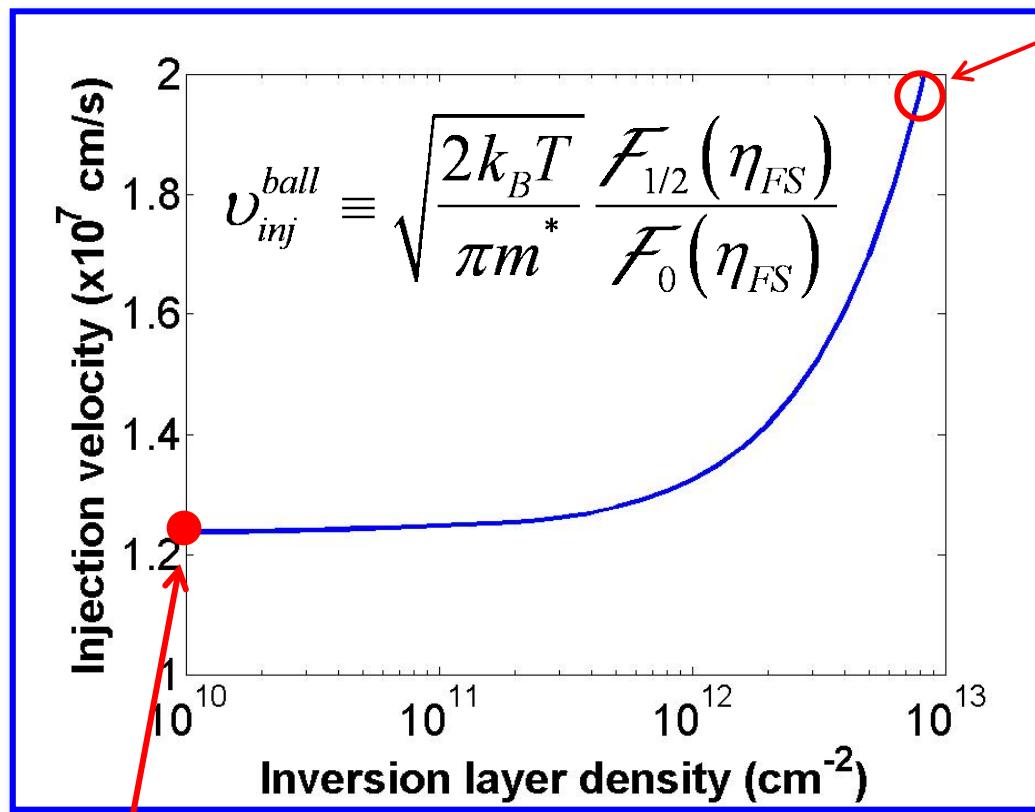
$$f(v_x, v_y)$$

E_X vs. x for $V_{GS} = 0.5V$



(Numerical simulations of an $L = 10$ nm double gate Si MOSFET from J.-H. Rhew and M.S. Lundstrom, *Solid-State Electron.*, **46**, 1899, 2002)

Ballistic injection velocity



$$v_{inj}^{ball} \rightarrow (4/3\pi) v_F$$

$$v_F = \sqrt{\frac{2(E_F - E_C)}{m^*}}$$

fully degenerate

$$v_T = \sqrt{2k_B T / \pi m^*}$$

non-degenerate

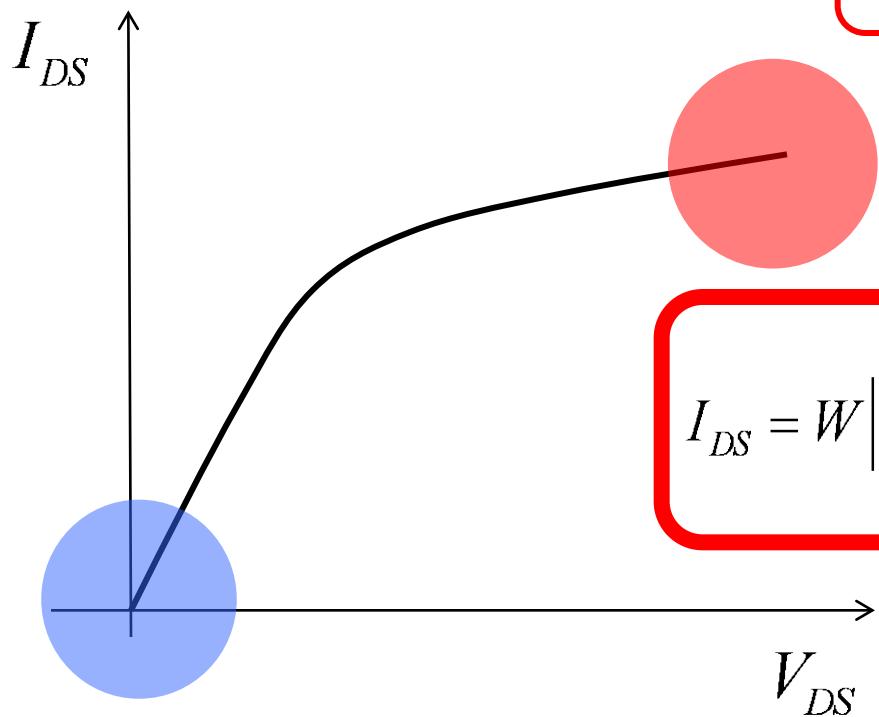
Comments on FD statistics

We have assumed 2D carriers, parabolic energy bands, and that a single subband at energy, E_C , is occupied.

For a 1D, nanowire MOSFET, with parabolic energy bands, the same general considerations apply, but the Fermi-Dirac integrals will be of different order.

See Lecture 13 of the Lecture Notes for more discussion.

Lecture 3.8: VS model



$$I_{DLIN} = \frac{W}{L} \mu_n |Q_n(V_{GS}, V_{DS})| V_{DS}$$

Connection to ballistic model

$$\frac{1}{\mu_n} \rightarrow \frac{1}{\mu_{app}} \quad \text{"apparent mobility"}$$

$$v_{sat} \rightarrow v_{inj} \quad \text{"injection velocity"}$$

Ballistic MOSFETs:

$$\mu_{app} = \mu_B \quad \mu_B = \frac{v_T L}{2 k_B T / q} \text{ cm}^2/\text{V-s}$$

(non-degenerate)

$$v_{inj} = v_{inj}^{ball} \quad v_{inj}^{ball} = v_T \quad v_T = \sqrt{\frac{2 k_B T}{\pi m^*}}$$

Our goal in Unit 3

A ballistic treatment of transport

$$I_{DS} = W |Q_n(V_{GS}, V_{DS})| \langle v(V_{GS}, V_{DS}) \rangle$$

Unit 2:
MOS electrostatics

Unit 4:

$$\mathcal{T}(E) \leq 1$$

$$\mathcal{T}(E) = 1$$

$$\langle v(V_{DS}) \rangle = v_T \left(\frac{1 - e^{-qV_{DS}/k_B T}}{1 + e^{-qV_{DS}/k_B T}} \right) \quad (\text{MB})$$

$$\langle v(V_{GS}, V_{DS}) \rangle = v_{inj}^{ball} \left[\frac{1 - \mathcal{F}_{1/2}(\eta_{FD}) / \mathcal{F}_{1/2}(\eta_{FS})}{1 + \mathcal{F}_0(\eta_{FD}) / \mathcal{F}_0(\eta_{FS})} \right]$$

$$v_{inj}^{ball} = \langle \langle v_x^+ \rangle \rangle = v_T \frac{\mathcal{F}_{1/2}(\eta_{FS})}{\mathcal{F}_0(\eta_{FS})}$$